

N-Channel Super Junction Power MOSFET $\, III \,$

General Description

The series of devices use advanced trench gate super junction technology and design to provide excellent RDS(ON) with low gate charge. This super junction MOSFET fits the industry's AC-DC SMPS requirements for PFC, AC/DC power conversion, and industrial power applications.

Features

- •New technology for high voltage device
- •Low on-resistance and low conduction losses
- •Small package
- ●Ultra Low Gate Charge cause lower driving requirements
- ●100% Avalanche Tested
- ●ROHS compliant

Application

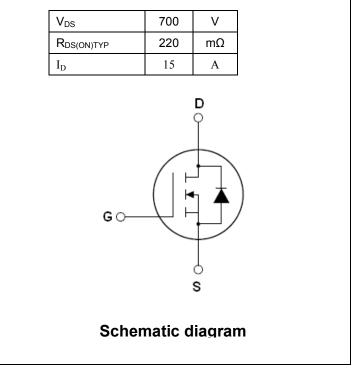
- Power factor correction (PFC)
- Switched mode power supplies(SMPS)
- Uninterruptible Power Supply (UPS)

Package	Marking	Δnd	Ordering	Information
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Device	Device Package	Marking	
NCE70T260K	TO-252	NCE70T260K	
NCE70T260I	TO-251	NCE70T260I	

Table 1. Absolute Maximum Ratings (T_c=25℃)

Parameter	Symbol	Value	Unit
Drain-Source Voltage (VGs=0V)	Vds	700	V
Gate-Source Voltage (VDs=0V) AC (f>1 Hz)	Vgs	±30	V
Continuous Drain Current at Tc=25°C	I _{D (DC)}	15	А
Continuous Drain Current at Tc=100°C	I _{D (DC)}	10	А
Pulsed drain current (Note 1)	DM (pluse)	60	А
Maximum Power Dissipation(Tc=25°C)	PD	131	W
Derate above 25°C		1.05	W/°C
Single pulse avalanche energy (Note 2)	Eas	304	mJ
Avalanche current ^(Note 1)	I _{AR}	3	А
Repetitive Avalanche energy , t_{AR} limited by T_{jmax} (Note 1)	E _{AR}	1.6	mJ





TO-252



TO-251



NCE70T260I,NCE70T260K,

Parameter	Symbol	Value	Unit
Drain Source voltage slope, $V_{DS} \leq 480 V$,	dv/dt	50	V/ns
Reverse diode dv/dt, $V_{DS} \leq 480 V, I_{SD} < I_D$	dv/dt	15	V/ns
Operating Junction and Storage Temperature Range	T _J ,T _{STG}	-55+150	°C

* limited by maximum junction temperature

Table 2. Thermal Characteristic

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case (Maximum)	R _{thJC}	0.95	°C /W
Thermal Resistance, Junction-to-Ambient (Maximum)	R _{thJA}	62	°C /W

Table 3. Electrical Characteristics (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
On/off states						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250µA	700			V
Zero Gate Voltage Drain Current(Tc=25℃)	I _{DSS}	V _{DS} =700V,V _{GS} =0V			1	μA
Zero Gate Voltage Drain Current(Tc=125℃)	I _{DSS}	V _{DS} =700V,V _{GS} =0V			100	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V			±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =250µA	3	3.5	4	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =8A		260	290	mΩ
Dynamic Characteristics						
Input Capacitance	Clss			1210	1400	pF
Output Capacitance	Coss	V _{DS} =50V,V _{GS} =0V,		74		pF
Reverse Transfer Capacitance	Crss	F=1.0MHz		0.2		pF
Total Gate Charge	Qg)/ _400)// _454		24.7	42	nC
Gate-Source Charge	Q _{gs}	- V _{DS} =480V,I _D =15A, V _{GS} =10V		8.2		nC
Gate-Drain Charge	Q _{gd}	VGS=10V		8.5		nC
Switching times						
Turn-on Delay Time	t _{d(on)}			15		nS
Turn-on Rise Time	tr	V _{DD} =420V,I _D =8A,		10		nS
Turn-Off Delay Time	t _{d(off)}	R _G =2.3Ω,V _{GS} =10V		57		nS
Turn-Off Fall Time	t _f			9		nS
Source- Drain Diode Characteristics						
Source-drain current(Body Diode)	I _{SD}	T -25%0			15	А
Pulsed Source-drain current(Body Diode)	I _{SDM}	- T _C =25°C			60	А
Forward On Voltage	V _{SD}	Tj=25°C,I _{SD} =15A,V _{GS} =0V		0.9	1.2	V
Reverse Recovery Time	t _{rr}			240		nS
Reverse Recovery Charge	Q _{rr}			2		uC
Peak Reverse Recovery Current	I _{rrm}	1		17		А

Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature

2. Tj=25°C,VDD=50V,VG=10V, R_G=25\Omega



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (curves)

Figure1. Safe operating area

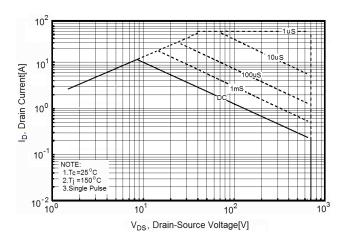


Figure3. Source-Drain Diode Forward Voltage

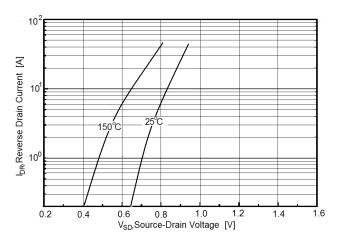


Figure5. Transfer characteristics

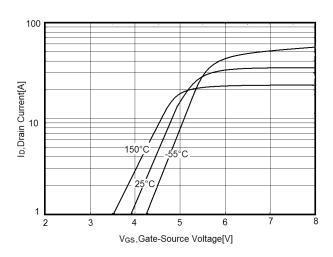


Figure2. Transient Thermal Impedance

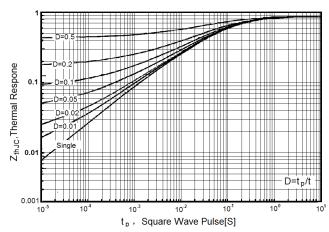


Figure4. Output characteristics

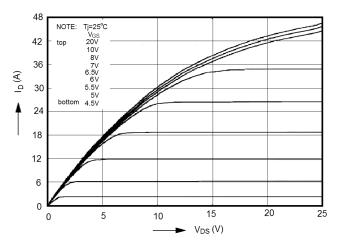


Figure6. Static drain-source on resistance

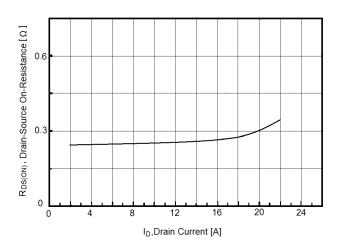
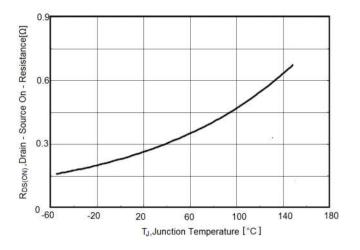




Figure8. BV_{DSS} vs Junction Temperature

Figure7. R_{DS(ON)} vs Junction Temperature



1.2 Vgs =0V I _ =250uA BV _{DSS} (Normalized) , Drain - Source Breakdown Voltage .1.1 0.8

-100

-50

0

50 T_J,Junction Temperature [°C]

100

150

200

Figure9. Maximum I_D vs Junction Temperature

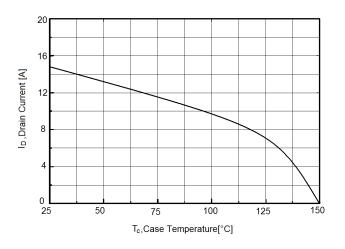
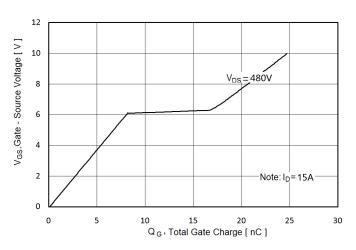
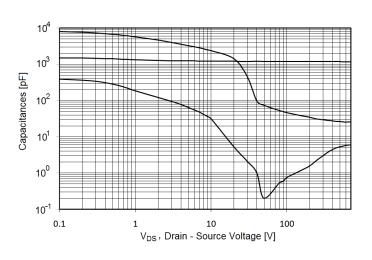


Figure10. Gate charge waveforms



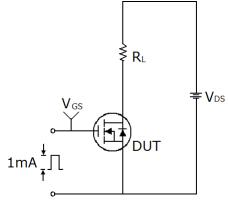


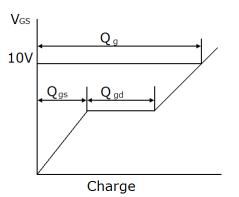




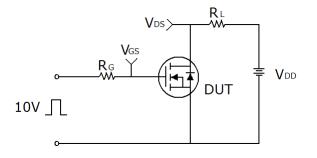
Test circuit

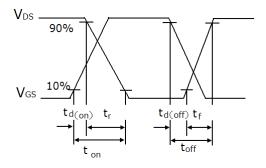
1) Gate charge test circuit & Waveform



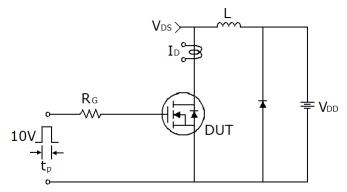


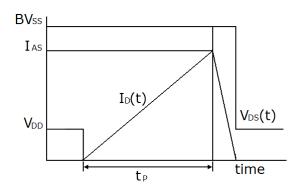
2) Switch Time Test Circuit:





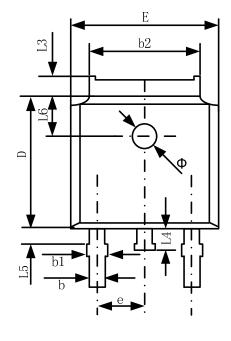
3) Unclamped Inductive Switching Test Circuit & Waveforms

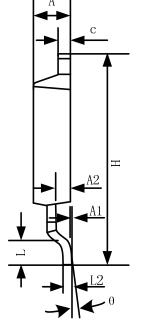


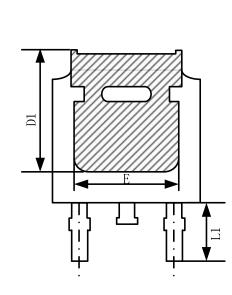




TO-252-2 Package Information



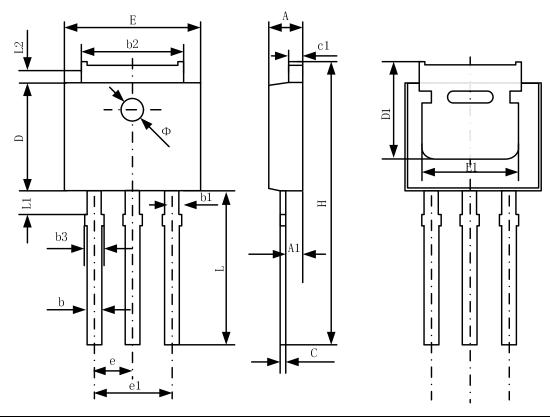




0. multi al	Dimensions	In Millimeters	Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
А	2.20	2.38	0.087	0.094	
A1	0.00	0.10	0.000	0.004	
A2	0.90	1.10	0.035	0.043	
b	0.72	0.85	0.028	0.033	
b1	0.72	0.90	0.028	0.035	
b2	5.13	5.46	0.202	0.215	
С	0.47	0.60	0.019	0.024	
D	6.00	6.20	0.236	0.244	
D1	5.25		0.207		
E	6.50	6.70	0.256	0.264	
E1	4.70		0.185		
e	2.19	2.39	0.086	0.094	
Н	9.80	10.40	0.386	0.409	
L	1.40	1.70	0.055	0.067	
L1	2.90) REF	0.114 REF		
L2	0.50	8 BSC	0.020 BSC		
L3	0.90	1.25	0.035	0.049	
L4	0.60	1.00	0.024	0.039	
L5	0.15	0.75	0.006	0.030	
L6	1.80 REF		0.07	1 REF	
Φ	1.20	1.40	0.047	0.055	
θ	0°	8°	0°	8°	



TO-251 Package Information



Symbol	Dimensions I	n Millimeters	Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
A	2.20	2.35	0.087	0.093	
A1	0.90	1.10	0.035	0.043	
b	0.56	0.69	0.022	0.027	
b1	0.77	0.90	0.030	0.035	
b2	5.23	5.43	0.206	0.214	
b3		1.05	0.000	0.041	
С	0.46	0.59	0.018	0.023	
c1	0.46	0.59	0.018	0.023	
D	6.00	6.20	0.236	0.244	
D1	5.20		0.205		
E	6.50	6.70	0.256	0.264	
E1	4.60	5.00	0.181		
e	2.24	2.34	0.088	0.092	
e1	4.47	4.67	0.176	0.184	
Н	16.18	16.78	0.637	0.661	
L	9.00	9.60	0.354	0.378	
L1	0.95	1.35	0.037	0.053	
L2	0.90	1.25	0.035	0.049	





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